

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MA138FK

## Low Voltage 3-to-8 Line Decoder with 3.6 V Tolerant Inputs and Outputs

The TC7MA138FK is a high performance CMOS 3-to-8 decoder which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5 V, 1.8 V, 2.5 V or 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

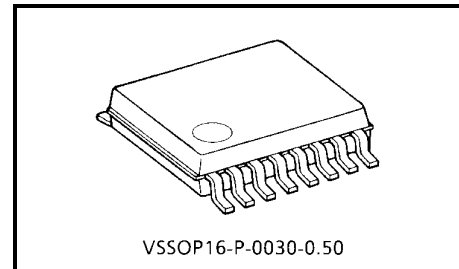
It is also designed with over voltage tolerant inputs and outputs up to 3.6 V.

When the device is enabled, 3 binary select inputs (A, B and C) determine which one of the outputs ( $\bar{Y}0$  -  $\bar{Y}7$ ) will go low.

When enable input G1 is held low or either  $\bar{G}2A$  or  $\bar{G}2B$  is held high, decoding function is inhibited and all outputs go high.

G1,  $\bar{G}2A$  and  $\bar{G}2B$  inputs are provided to ease cascade connection and for use as an address decoder for memory systems.

All inputs are equipped with protection circuits against static discharge.



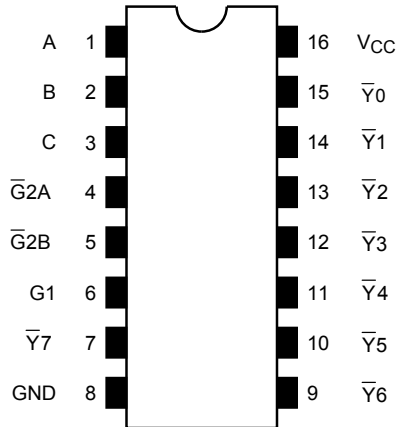
VSSOP16-P-0030-0.50

Weight: 0.02 g (typ.)

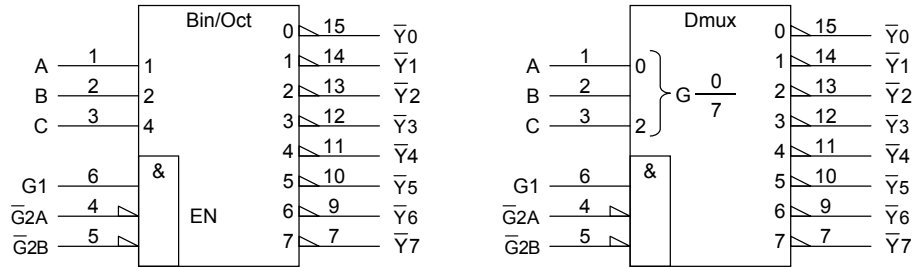
### Features

- Low voltage operation:  $V_{CC} = 1.2\sim 3.6\text{ V}$
- High speed operation:  $t_{pd} = 3.5\text{ ns (max) (}V_{CC} = 3.0\sim 3.6\text{ V)}$   
 $t_{pd} = 4.1\text{ ns (max) (}V_{CC} = 2.3\sim 2.7\text{ V)}$   
 $t_{pd} = 8.2\text{ ns (max) (}V_{CC} = 1.65\sim 1.95\text{ V)}$   
 $t_{pd} = 16.4\text{ ns (max) (}V_{CC} = 1.4\sim 1.6\text{ V)}$   
 $t_{pd} = 41.0\text{ ns (max) (}V_{CC} = 1.2\text{ V)}$
- 3.6 V tolerant inputs and outputs.
- Output current:  $I_{OH}/I_{OL} = \pm 24\text{ mA (min) (}V_{CC} = 3.0\text{ V)}$   
 $I_{OH}/I_{OL} = \pm 18\text{ mA (min) (}V_{CC} = 2.3\text{ V)}$   
 $I_{OH}/I_{OL} = \pm 6\text{ mA (min) (}V_{CC} = 1.65\text{ V)}$   
 $I_{OH}/I_{OL} = \pm 2\text{ mA (min) (}V_{CC} = 1.4\text{ V)}$
- Latch-up performance:  $-300\text{ mA}$
- ESD performance: Machine model  $\geq \pm 200\text{ V}$   
Human body model  $\geq \pm 2000\text{ V}$
- Package: VSSOP (US)
- Power down protection is provided on all inputs and outputs.

**Pin Assignment (top view)**



**IEC Logic Symbol**

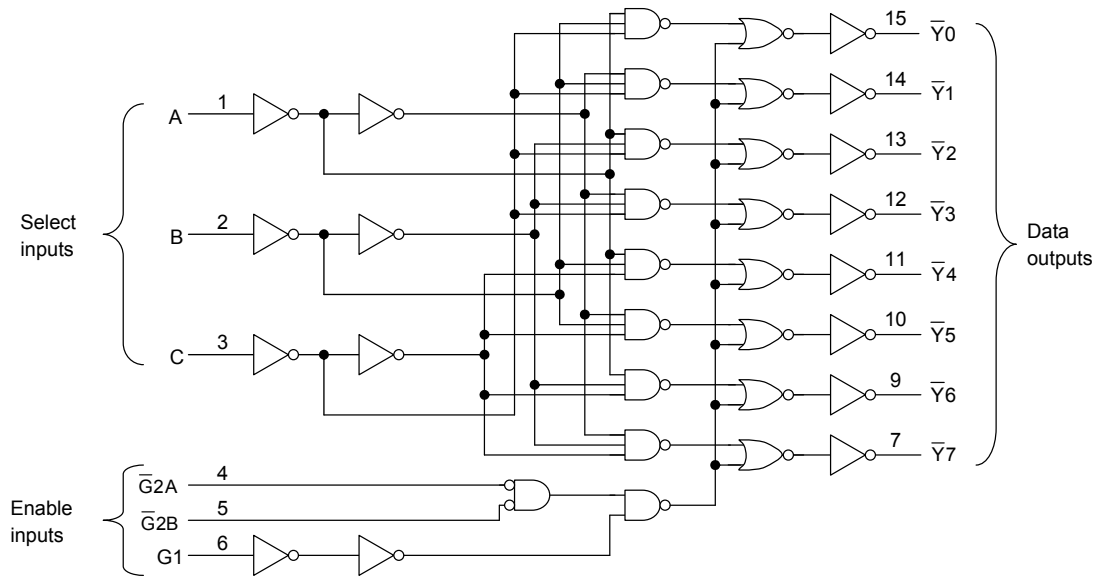


**Truth Table**

Inputs						Outputs								Selected Output
Enable			Select			$\bar{Y}_0$	$\bar{Y}_1$	$\bar{Y}_2$	$\bar{Y}_3$	$\bar{Y}_4$	$\bar{Y}_5$	$\bar{Y}_6$	$\bar{Y}_7$	
G1	$\bar{G}2A$	$\bar{G}2B$	C	B	A									
L	X	X	X	X	X	H	H	H	H	H	H	H	H	None
X	H	X	X	X	X	H	H	H	H	H	H	H	H	None
X	X	H	X	X	X	H	H	H	H	H	H	H	H	None
H	L	L	L	L	L	L	H	H	H	H	H	H	H	$\bar{Y}_0$
H	L	L	L	L	H	H	L	H	H	H	H	H	H	$\bar{Y}_1$
H	L	L	L	H	L	H	H	L	H	H	H	H	H	$\bar{Y}_2$
H	L	L	L	H	H	H	H	H	L	H	H	H	H	$\bar{Y}_3$
H	L	L	H	L	L	H	H	H	H	L	H	H	H	$\bar{Y}_4$
H	L	L	H	L	H	H	H	H	H	H	L	H	H	$\bar{Y}_5$
H	L	L	H	H	L	H	H	H	H	H	H	L	H	$\bar{Y}_6$
H	L	L	H	H	H	H	H	H	H	H	H	H	L	$\bar{Y}_7$

X: Don't care

**System Diagram**



**Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5~4.6	V
DC input voltage	$V_{IN}$	-0.5~4.6	V
DC output voltage	$V_{OUT}$	-0.5~4.6 (Note 2)	V
		-0.5~ $V_{CC} + 0.5$ (Note 3)	
Input diode current	$I_{IK}$	-50	mA
Output diode current	$I_{OK}$	±50 (Note 4)	mA
DC output current	$I_{OUT}$	±50	mA
Power dissipation	$P_D$	180	mW
DC $V_{CC}$ /ground current	$I_{CC}/I_{GND}$	±100	mA
Storage temperature	$T_{stg}$	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2:  $V_{CC} = 0$  V

Note 3: High or low state.  $I_{OUT}$  absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND, V_{OUT} > V_{CC}$

## Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	1.2~3.6	V
Input voltage	$V_{IN}$	-0.3~3.6	V
Output voltage	$V_{OUT}$	0~3.6 (Note 2)	V
		0~ $V_{CC}$ (Note 3)	
Output current	$I_{OH}/I_{OL}$	$\pm 24$ (Note 4)	mA
		$\pm 18$ (Note 5)	
		$\pm 6$ (Note 6)	
		$\pm 2$ (Note 7)	
Operating temperature	$T_{opr}$	-40~85	°C
Input rise and fall time	dt/dv	0~10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.  
Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 2:  $V_{CC} = 0$  V

Note 3: High or low state

Note 4:  $V_{CC} = 3.0\sim 3.6$  V

Note 5:  $V_{CC} = 2.3\sim 2.7$  V

Note 6:  $V_{CC} = 1.65\sim 1.95$  V

Note 7:  $V_{CC} = 1.4\sim 1.6$  V

Note 8:  $V_{IN} = 0.8\sim 2.0$  V,  $V_{CC} = 3.0$  V

## Electrical Characteristics

### DC Characteristics ( $T_a = -40\sim 85^\circ\text{C}$ , $2.7\text{ V} < V_{CC} \leq 3.6\text{ V}$ )

Characteristics		Symbol	Test Condition	$V_{CC}$ (V)	Min	Max	Unit	
Input voltage	High level	$V_{IH}$	—	2.7~3.6	2.0	—	V	
	Low level	$V_{IL}$	—	2.7~3.6	—	0.8		
Output voltage	High level	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -100\ \mu\text{A}$	2.7~3.6	$V_{CC} - 0.2$	—	V
				$I_{OH} = -12\ \text{mA}$	2.7	2.2	—	
				$I_{OH} = -18\ \text{mA}$	3.0	2.4	—	
				$I_{OH} = -24\ \text{mA}$	3.0	2.2	—	
	Low level	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 100\ \mu\text{A}$	2.7~3.6	—	0.2	
				$I_{OL} = 12\ \text{mA}$	2.7	—	0.4	
				$I_{OL} = 18\ \text{mA}$	3.0	—	0.4	
				$I_{OL} = 24\ \text{mA}$	3.0	—	0.55	
Input leakage current		$I_{IN}$	$V_{IN} = 0\sim 3.6\text{ V}$	2.7~3.6	—	$\pm 5.0$	$\mu\text{A}$	
Power off leakage current		$I_{OFF}$	$V_{IN}, V_{OUT} = 0\sim 3.6\text{ V}$	0	—	10.0	$\mu\text{A}$	
Quiescent supply current		$I_{CC}$	$V_{IN} = V_{CC}$ or GND	2.7~3.6	—	20.0	$\mu\text{A}$	
			$V_{CC} \leq V_{IN} \leq 3.6\text{ V}$	2.7~3.6	—	$\pm 20.0$		
Increase in $I_{CC}$ per input		$\Delta I_{CC}$	$V_{IH} = V_{CC} - 0.6\text{ V}$	2.7~3.6	—	750		

**DC Characteristics (Ta = -40~85°C, 2.3 V ≤ VCC ≤ 2.7 V)**

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	High level	V <sub>IH</sub>	—		2.3~2.7	1.6	—	V
	Low level	V <sub>IL</sub>	—		2.3~2.7	—	0.7	
Output voltage	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	2.3~2.7	V <sub>CC</sub> - 0.2	—	V
				I <sub>OH</sub> = -6 mA	2.3	2.0	—	
				I <sub>OH</sub> = -12 mA	2.3	1.8	—	
				I <sub>OH</sub> = -18 mA	2.3	1.7	—	
	Low level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.3~2.7	—	0.2	
				I <sub>OL</sub> = 12 mA	2.3	—	0.4	
I <sub>OL</sub> = 18 mA				2.3	—	0.6		
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		2.3~2.7	—	±5.0	μA
Power off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3~2.7	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		2.3~2.7	—	±20.0	

**DC Characteristics (Ta = -40~85°C, 1.65 V ≤ VCC < 2.3 V)**

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	High level	V <sub>IH</sub>	—		1.65~2.3	0.65 × V <sub>CC</sub>	—	V
	Low level	V <sub>IL</sub>	—		1.65~2.3	—	0.2 × V <sub>CC</sub>	
Output voltage	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.65~2.3	V <sub>CC</sub> - 0.2	—	V
				I <sub>OH</sub> = -6 mA	1.65	1.25	—	
	Low level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.65~2.3	—	0.2	
				I <sub>OL</sub> = 6 mA	1.65	—	0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		1.65	—	±5.0	μA
Power off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.65~2.3	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		1.65~2.3	—	±20.0	

**DC Characteristics (Ta = -40~85°C, 1.4V ≤ VCC < 1.65V)**

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	High level	V <sub>IH</sub>	—		1.4~1.65	0.65 V <sub>CC</sub>	—	V
	Low level	V <sub>IL</sub>	—		1.4~1.65	—	0.05 × V <sub>CC</sub>	
Output voltage	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.4~1.65	V <sub>CC</sub> - 0.2	—	V
				I <sub>OH</sub> = -2 mA	1.4	1.05	—	
	Low level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.4~1.65	—	0.05	
				I <sub>OL</sub> = 2 mA	1.4	—	0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		1.4~1.65	—	±5.0	μA
Power off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.4~1.65	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		1.4~1.65	—	±20.0	

**DC Characteristics (Ta = -40~85°C, 1.2 V ≤ VCC < 1.4 V)**

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	High level	V <sub>IH</sub>	—		1.2~1.4	0.8 × V <sub>CC</sub>	—	V
	Low level	V <sub>IL</sub>	—		1.2~1.4	—	0.05 × V <sub>CC</sub>	
Output voltage	High level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -100 μA	1.2	V <sub>CC</sub> - 0.1	—	V
	Low level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.2	—	0.05	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0~3.6 V		1.2	—	±5.0	μA
Power off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0~3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.2	—	20.0	μA
			V <sub>CC</sub> ≤ V <sub>IN</sub> ≤ 3.6 V		1.2	—	±20.0	

**AC Characteristics (Ta = -40~85°C, Input: tr = tf = 2.0 ns)**

Characteristics	Symbol	Test Condition		VCC (V)	Min	Max	Unit
Propagation delay time (A, B, C- $\bar{Y}$ )	tpLH tpHL	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	3.0	41.0	ns
				1.4 ± 0.1	2.0	16.4	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.5	8.2	
				2.5 ± 0.2	0.8	4.1	
Propagation delay time (G1- $\bar{Y}$ )	tpLH tpHL	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	3.0	41.0	ns
				1.4 ± 0.1	2.0	16.4	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.5	8.2	
				2.5 ± 0.2	0.8	4.1	
Propagation delay time (G2- $\bar{Y}$ )	tpLH tpHL	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	3.0	41.0	ns
				1.4 ± 0.1	2.0	16.4	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.5	8.2	
				2.5 ± 0.2	0.8	4.1	
				3.3 ± 0.3	0.6	3.5	

For CL = 50 pF, add approximately 300 ps to the AC maximum specification.

**Dynamic Switching Characteristics (Ta = 25°C, Input: tr = tf = 2.0 ns, CL = 30 pF)**

Characteristics	Symbol	Test Condition		VCC (V)	Typ.	Unit
Quiet output maximum dynamic VOL	VOLP	VIH = 1.8 V, VIL = 0 V	(Note)	1.8	0.25	V
				2.5	0.6	
				3.3	0.8	
Quiet output minimum dynamic VOL	VOLV	VIH = 1.8 V, VIL = 0 V	(Note)	1.8	-0.25	V
				2.5	-0.6	
				3.3	-0.8	
Quiet output minimum dynamic VOH	VOHV	VIH = 1.8 V, VIL = 0 V	(Note)	1.8	1.5	V
				2.5	1.9	
				3.3	2.2	

Note: This parameter is guaranteed by design.

**Capacitive Characteristics (Ta = 25°C)**

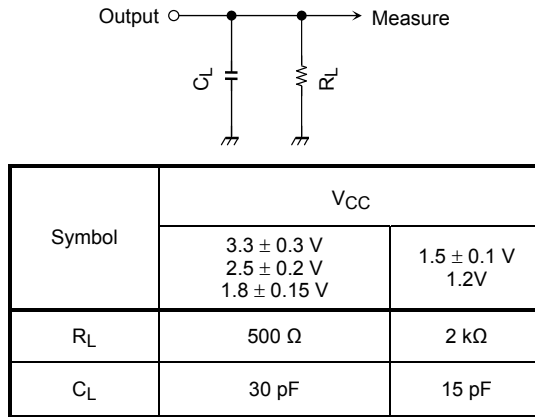
Characteristics	Symbol	Test Condition		VCC (V)	Typ.	Unit
Input capacitance	CIN	—		1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	CPD	fIN = 10 MHz	(Note)	1.8, 2.5, 3.3	40	pF

Note: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

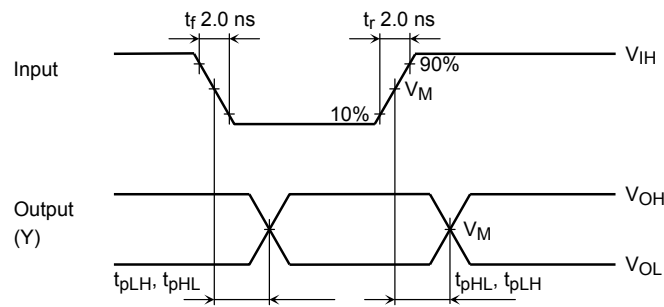
$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

**AC Test Circuit**



**Figure 1**

**AC Waveform**



Symbol	$V_{CC}$				
		$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	$1.8 \pm 0.15 \text{ V}$	$1.5 \pm 0.1 \text{ V}$
$V_{IH}$	2.7 V	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$
$V_M$	1.5 V	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$

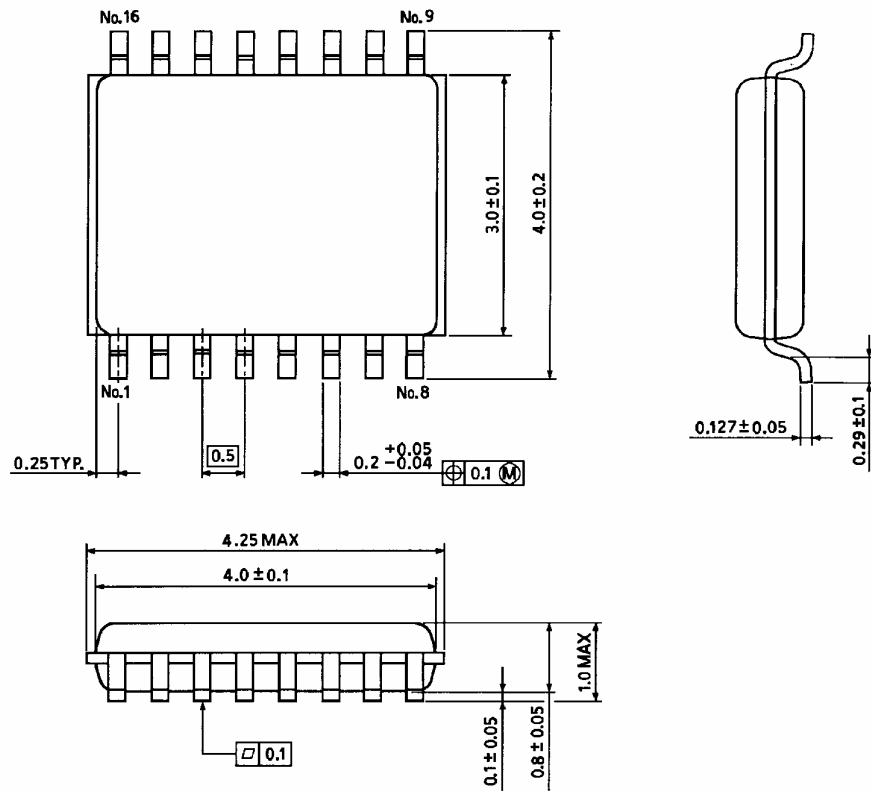
**Figure 2  $t_{pLH}$ ,  $t_{pHL}$**



## Package Dimensions

VSSOP16-P-0030-0.50

Unit : mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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